## Applicant(s)/Patent Under Application/Control No. Reexamination 10/063,979 DEWANJEE ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 1712 David Buttner **U.S. PATENT DOCUMENTS** Document Number Country Code-Number-Kind Code Date Classification Name MM-YYYY 528/64 09-2004 Dewanjee, Pijush K. US-6,787,626 Α 528/64 US-6,762,273 07-2004 Dewanjee, Pijush K. В US-С US-D Ε US-US-F US-G US-Н USı US-J US-Κ US-L М US-FOREIGN PATENT DOCUMENTS Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U

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